

Notice of References Cited

Application/Control No.

10/525,770

Applicant(s)/Patent Under
Reexamination
SHIRAI ET AL.

Examiner

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Art Unit

3751

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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	E	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001152520 A	06-2001	Japan	Yamazaki et al.	E03D 009/8
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

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